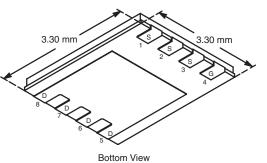


Vishay Siliconix

N-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^f Q _g (Ty				
20	0.0045 at V _{GS} = 10 V	35 ^g	13.2 nC			
	0.0058 at V _{GS} = 4.5 V	35 ^g	13.2 110			



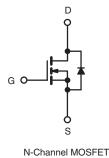
PowerPAK 1212-8



- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested •
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- POL
- DC/DC



Ordering Information: SiS426DN-T1-GE3 (Lead (Pb)-free and Halogen-free)

ABSOLUTE MAXIMUM RATINGS $T_A = 25 \degree C$, unless otherwise noted					
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	20	V	
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C	_	35 ^g		
Continuous Drain Current ($T_1 = 150 \ ^{\circ}C$)	T _C = 70 °C		35 ^g		
Continuous Drain Current $(1) = 150^{\circ}$ C)	T _A = 25 °C	I _D	22.0 ^{a, b}		
	T _A = 70 °C		20.0 ^{a, b}	A	
Pulsed Drain Current		I _{DM}	70	A	
Continuous Source-Drain Diode Current	T _C = 25 °C	- I _S	35 ^g		
Continuous Source-Drain Diode Current	T _A = 25 °C		3.3 ^{a, b}		
Single Pulse Avalanche Current L = 0.1 m		I _{AS}	20		
Single Pulse Avalanche Energy		E _{AS}	20	mJ	
	T _C = 25 °C		52		
Maximum Power Dissipation	T _C = 70 °C	P _D	43	W	
	T _A = 25 °C		3.7 ^{a, b}		
	T _A = 70 °C		3.1 ^{a, b}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{c, d}			260		

THERMAL RESISTANCE RATINGS

I RENMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{a, e}	t ≤ 10 s	R _{thJA}	24	33	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	1.9	2.4	0/11		

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.

- c. See solder profile (<u>www.vishay.com/ppg?73257</u>). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
 d. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
 e. Maximum under steady state conditions is 81 °C/W.

f. Based on $T_C = 25$ °C. g. Package limited.



FREE

SiS426DN

Vishay Siliconix



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					1		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$	20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			20		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 4.5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	1.2		2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zero Gate Voltage Drain Current		$V_{DS} = 20 V, V_{GS} = 0 V$	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$		1		
	IDSS	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	- μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	20			A	
Drain-Source On-State Resistance ^a		V _{GS} = 10 V, I _D = 10 A		0.0033	0.0045		
	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 7 A		0.0046	0.0058	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 10 V, I _D = 10 A		50		S	
Dynamic ^b	<u> </u>				<u> </u>		
Input Capacitance	C _{iss}			1570			
Output Capacitance	C _{oss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		555		pF	
Reverse Transfer Capacitance	C _{rss}			195			
		V _{DS} = 10 V, V _{GS} = 10 V, I _D = 10 A		28	42	nC	
Total Gate Charge	Q _g			13.2	20		
Gate-Source Charge	Q _{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		3.8			
Gate-Drain Charge	Q _{gd}			4.0			
Gate Resistance	Rg	f = 1 MHz	0.2	0.70	1.4	Ω	
Turn-On Delay Time	t _{d(on)}			21	35	ns	
Rise Time	t _r	V_{DD} = 10 V, R_L = 1 Ω		13	26		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10$ Å, $V_{GEN} = 4.5$ V, $R_g = 1$ Ω		29	55		
Fall Time	t _f			17	30		
Turn-On Delay Time	t _{d(on)}			10	20		
Rise Time	t _r	V_{DD} = 10 V, R_L = 1 Ω		8	16		
Turn-Off Delay Time	t _{d(off)}	$\rm I_D \cong 10$ A, $\rm V_{GEN}$ = 10 V, $\rm R_g$ = 1 Ω		22	40		
Fall Time	t _f			8	16		
Drain-Source Body Diode Characteristic	cs				I		
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			35	•	
Pulse Diode Forward Current	I _{SM}				70	A	
Body Diode Voltage	V _{SD}	$I_{S} = 3 A, V_{GS} = 0 V$		0.75	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			22	44	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			10	20	nC	
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 ^\circ\text{C}$		11			
Reverse Recovery Rise Time	t _b			11		ns	

Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



SiS426DN

Vishay Siliconix

- 55 °C T_C =

4

3

2

Coss

50

75

100

12

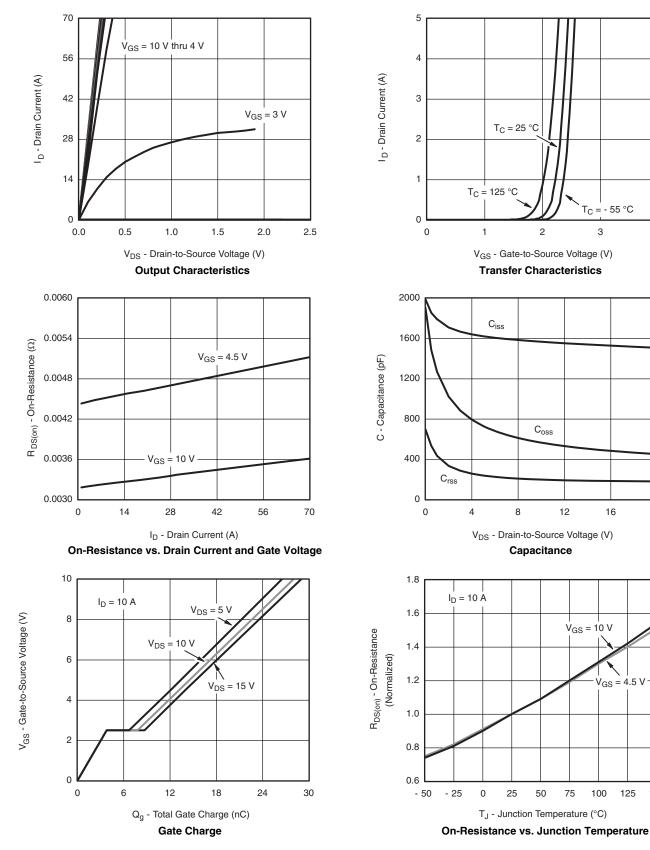
16

 $V_{GS} = 10 V$

V_{GS} = 4.5 V

20

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



125

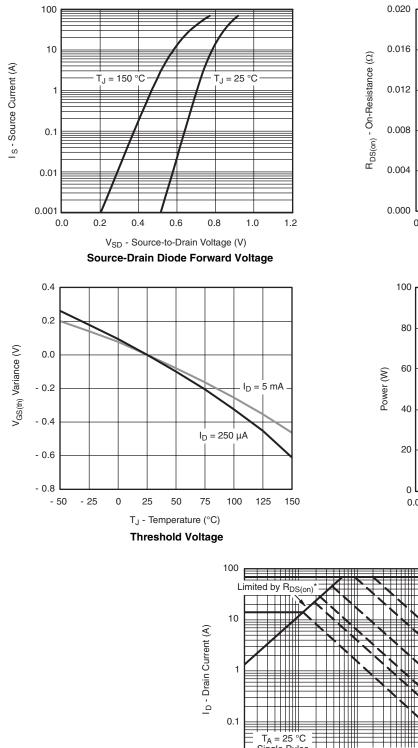
150

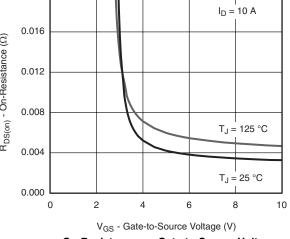
SiS426DN

Vishay Siliconix

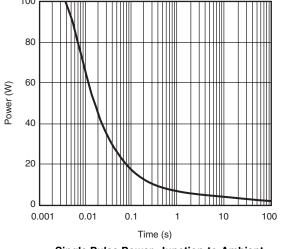


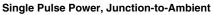
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





On-Resistance vs. Gate-to-Source Voltage

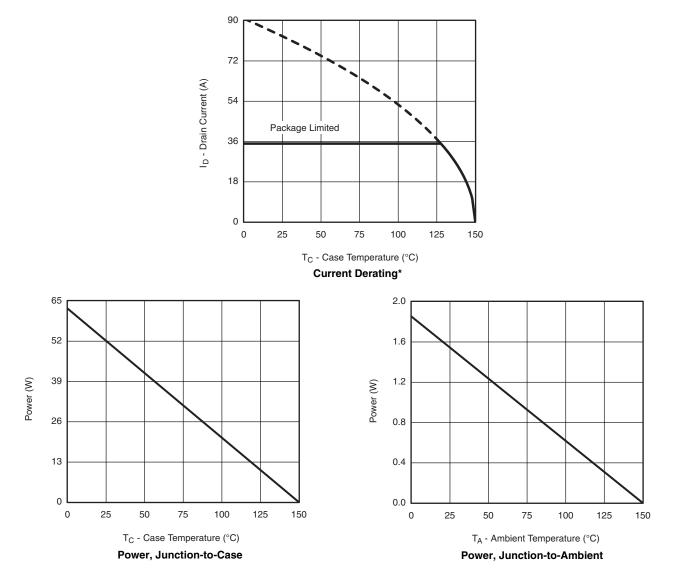




1 ms 10 ms 100 ms DC Single Pulse **BVDSS** Limited 11111 0.01 0.01 10 0.1 1 100 V_{DS} - Drain-to-Source Voltage (V) * V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified Safe Operating Area, Junction-to-Ambient



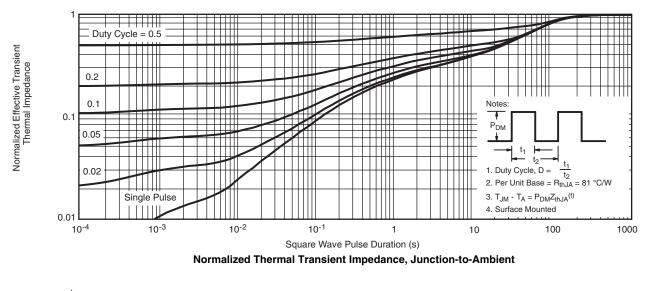
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

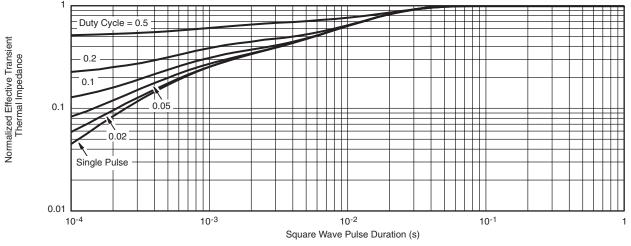


* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

Vishay Siliconix

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?68799.



Vishay

Disclaimer

All product specifications and data are subject to change without notice.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained herein or in any other disclosure relating to any product.

Vishay disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications unless otherwise expressly indicated. Customers using or selling Vishay products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify Vishay for any damages arising or resulting from such use or sale. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

Product names and markings noted herein may be trademarks of their respective owners.